Issue Classification

(Primary Examiner)

Application/Control No.	Applicant(s)/Patent Under Reexamination							
10086697	SHINOHARA ET AL.							

Examiner	Art Unit		
KIRSTEN S APPLE	3694		

ORIGINAL						INTERNATIONAL CLASSIFICATION										
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CROSS REFERENCE(S)					G	0	6	Q	40 / 00 (2006.0	1.01)						
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